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| Notice of References Cited | Application/Control No. 10/659,272 | Applicant(s)/Patent Under Reexamination SAITO ET AL. | |
| | Examiner Enoch E Peavey | Art Unit 3676 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-2003/0022005 | 01-2003 | Miyashita et al. | 428/465 |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
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